Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/608,475	SAITOH, HIROMI	
Examiner	Art Unit	
Toan Ton	2871	

SEARCHED						
Class	Subclass	Date	Examiner			
349	158	3/29/2005	TTON			
	110		_			
	153					

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
349	158	3/29/2005	TTON			
	110					
	153					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST liquid crystal light shield\$5/block\$5 black matrix.mask size, length seal\$5 peripher\$/external\$5	3/29/2005	TTON		